

# **SiC JFET Division**

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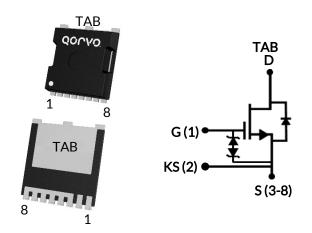








# UJ4SC075018L8S



Part Number	Package	Marking
UJ4SC075018L8S	MO-229	UJ4SC075018







# Silicon Carbide (SiC) Cascode JFET -EliteSiC, Power N-Channel, TOLL, 750 V, 18 mohm

Rev B, January 2025

### Description

The UJ4SC075018L8S is a 750V,  $18m\Omega$  G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows use of off-the-shelf gate drivers hence requiring minimal re-design when replacing Si IGBTs, Si superjunction devices or SiC MOSFETs. Available in the space-saving MO-229 package which enables automated assembly, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

#### **Features**

- On-resistance R<sub>DS(on)</sub>: 18mΩ (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q<sub>rr</sub> = 128nC
- ◆ Low body diode V<sub>FSD</sub>: 1.14V
- Low gate charge: Q<sub>G</sub> = 37.8nC
- Threshold voltage V<sub>G(th)</sub>: 4.8V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected, HBM class 2
- MO-229 package for faster switching, clean gate waveforms

### Typical applications

- Solid state relays and circuit-breakers
- Line rectification and active-bridge rectification circuits in AC/DC front-ends
- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating















# **Maximum Ratings**

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	$V_{DS}$		750	V
Gate-source voltage	$V_{GS}$	DC	-20 to +20	V
Gate-source voltage	V GS	AC (f > 1Hz)	-25 to +25	V
Continuous drain current <sup>1</sup>	I <sub>D</sub>	T <sub>C</sub> < 118°C	53	Α
Pulsed drain current <sup>2</sup>	I <sub>DM</sub>	T <sub>C</sub> = 25°C	208	Α
Single pulsed avalanche energy <sup>3</sup>	E <sub>AS</sub>	L=15mH, I <sub>AS</sub> =3.6A	97.2	mJ
SiC FET dv/dt Ruggedness	dv/dt <sub>rug</sub>	V <sub>DS</sub> <500V	200	V/ns
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25°C	349	W
Maximum junction temperature	$T_{J,max}$		175	°C
Operating and storage temperature	$T_J, T_{STG}$		-55 to 175	°C
Reflow soldering temperature	$T_{solder}$	reflow MSL 1	260	°C

- 1. Limited by bondwires
- 2. Pulse width  $t_p$  limited by  $T_{J,max}$
- 3. Starting  $T_J = 25$ °C

# **Thermal Characteristics**

Parameter	Symbol	Test Conditions	Value			Units
Parameter	Syllibol	Test Conditions	Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{ heta JC}$			0.33	0.43	°C/W













# Electrical Characteristics (T<sub>J</sub> = +25°C unless otherwise specified)

# **Typical Performance - Static**

Parameter	Symbol	Test Conditions		Value		- Units	
Parameter	Зуппоп	Test Conditions	Min Typ		Max	Offics	
Drain-source breakdown voltage	BV <sub>DS</sub>	$V_{GS}$ =0V, $I_D$ =1mA	750			V	
		V <sub>DS</sub> =750V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C		1.3	45		
Total drain leakage current	I <sub>DSS</sub>	V <sub>DS</sub> =750V, V <sub>DS</sub> =0V, T <sub>J</sub> =175°C		20		- μΑ	
Total gate leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, T <sub>J</sub> =25°C, V <sub>GS</sub> =-20V / +20V		4.7	20	μА	
		V <sub>GS</sub> =12V, I <sub>D</sub> =50A, T <sub>J</sub> =25°C		18	23		
Drain-source on-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =12V, I <sub>D</sub> =50A, T <sub>J</sub> =125°C		29		mΩ	
		V <sub>GS</sub> =12V, I <sub>D</sub> =50A, T <sub>J</sub> =175°C		37			
Gate threshold voltage	$V_{G(th)}$	$V_{DS}$ =5V, $I_{D}$ =10mA	4	4.8	6	V	
Gate resistance	$R_{G}$	f=1MHz, open drain		4.5		Ω	

# Typical Performance - Reverse Diode

Parameter	Symbol	Toot Conditions	Value			11
Faranietei	Symbol	Test Conditions	Min	Тур	Max	Units
Diode continuous forward current <sup>1</sup>	I <sub>S</sub>	T <sub>C</sub> < 118°C			53	Α
Diode pulse current <sup>2</sup>	$I_{S,pulse}$	T <sub>C</sub> =25°C			208	Α
Famuurd valtaga	V <sub>FSD</sub>	$V_{GS}$ =0V, $I_{S}$ =20A, $T_{J}$ =25°C		1.14	1.46	V
Forward voltage		V <sub>GS</sub> =0V, I <sub>S</sub> =20A, T <sub>J</sub> =175°C		1.35		
Reverse recovery charge	$Q_{rr}$	$V_{DS}$ =400V, $I_{S}$ =50A, $V_{GS}$ =-0V, $R_{G}$ =50 $\Omega$		128		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=1500A/μs, T <sub>J</sub> =25°C		26.4		ns
Reverse recovery charge	$Q_{rr}$	$V_{DS}$ =400V, $I_{S}$ =50A, $V_{GS}$ =-0V, $R_{G}$ =50 $\Omega$		138		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=1500A/μs, Τ <sub>J</sub> =150°C		28		ns















# Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
Parameter	Symbol	Test Conditions -	Min	Тур	Max	Offics
Input capacitance	C <sub>iss</sub>	- V <sub>DS</sub> =400V, V <sub>GS</sub> =0V -		1414		
Output capacitance	C <sub>oss</sub>	f=100kHz		118		pF
Reverse transfer capacitance	$C_{rss}$	I-100KHZ		2		
Effective output capacitance, energy related	C <sub>oss(er)</sub>	V <sub>DS</sub> =0V to 400V, V <sub>GS</sub> =0V		150		pF
Effective output capacitance, time related	C <sub>oss(tr)</sub>	V <sub>DS</sub> =0V to 400V, V <sub>GS</sub> =0V		280		pF
C <sub>OSS</sub> stored energy	E <sub>oss</sub>	$V_{DS}$ =400V, $V_{GS}$ =0V		12		μЈ
Total gate charge	$Q_{G}$	- V <sub>DS</sub> =400V, I <sub>D</sub> =50A, -		37.8		
Gate-drain charge	$Q_{GD}$	$V_{DS} = 400 \text{ V}, V_{DS} = 500 \text{ A},$		8		nC
Gate-source charge	$Q_{GS}$			11.8		
Turn-on delay time	t <sub>d(on)</sub>	Note 4, V <sub>DS</sub> =400V, I <sub>D</sub> =50A,		13.6		- ns
Rise time	t <sub>r</sub>	Gate Driver = 0V to +15V,		26.4		
Turn-off delay time	$t_{d(off)}$	Turn-on $R_{G,EXT}$ =1 $\Omega$ ,		134		
Fall time	t <sub>f</sub>	Turn-off $R_{G,EXT}$ =50 $\Omega$		18.4		
Turn-on energy	E <sub>ON</sub>	Inductive Load, FWD: same device with		234		μЈ
Turn-off energy	E <sub>OFF</sub>	$V_{GS} = 0V, R_G = 50\Omega,$		216		
Total switching energy	E <sub>TOTAL</sub>	T <sub>J</sub> =25°C		450		
Turn-on delay time	t <sub>d(on)</sub>	Note 4,		13		
Rise time	t <sub>r</sub>	V <sub>DS</sub> =400V, I <sub>D</sub> =50A,		31		ne
Turn-off delay time	$t_{d(off)}$	$\begin{array}{c} \text{Gate Driver = 0V to +15V,} \\ \text{Turn-on R}_{\text{G,EXT}} = 1\Omega, \\ \text{Turn-off R}_{\text{G,EXT}} = 50\Omega \end{array}$		136		ns
Fall time	t <sub>f</sub>			18.4		
Turn-on energy	E <sub>ON</sub>	Inductive Load, - FWD: same device with		272		
Turn-off energy	E <sub>OFF</sub>	$V_{GS} = 0V$ , $R_G = 50\Omega$ ,		258		μJ
Total switching energy	E <sub>TOTAL</sub>	T <sub>J</sub> =150°C		530		

 $<sup>4.\,</sup>Measured\,with\,the\,half-bridge\,mode\,switching\,test\,circuit\,in\,Figure\,23.$ 







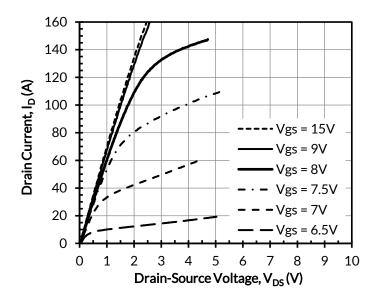








### **Typical Performance Diagrams**



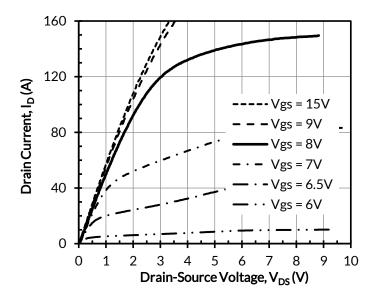
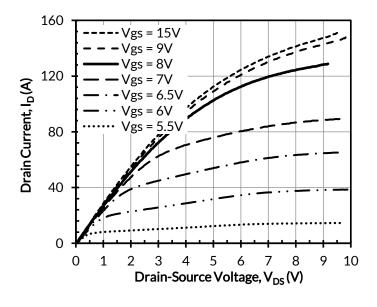


Figure 1. Typical output characteristics at  $T_J = -55$ °C, tp Figure 2. Typical output characteristics at  $T_J = 25$ °C, tp < < 250µs

250µs



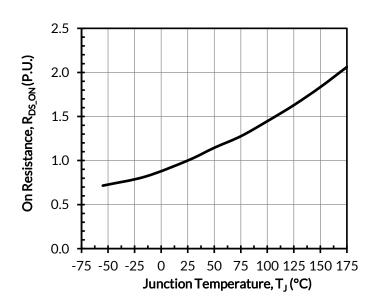


Figure 3. Typical output characteristics at  $T_J = 175$ °C, tp Figure 4. Normalized on-resistance vs. temperature at < 250µs

 $V_{GS}$  = 12V and  $I_D$  = 50A





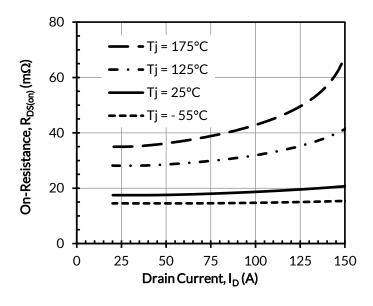








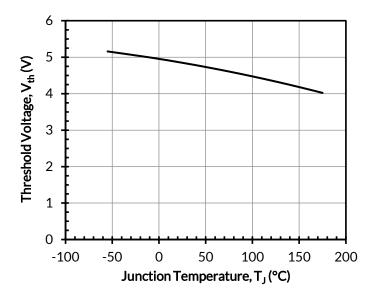




Tj = -55°C Tj = 25°C Drain Current, I<sub>D</sub> (A) Tj = 175°C Gate-Source Voltage,  $V_{GS}(V)$ 

Figure 5. Typical drain-source on-resistances at  $V_{GS}$  = 12V

Figure 6. Typical transfer characteristics at  $V_{DS} = 5V$ 



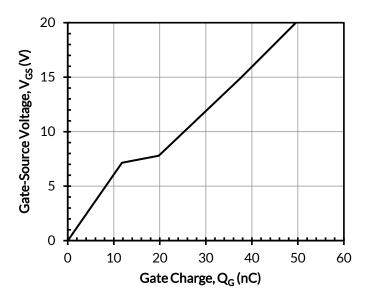


Figure 7. Threshold voltage vs. junction temperature at  $V_{DS}$  = 5V and  $I_{D}$  = 10mA

Figure 8. Typical gate charge at  $V_{DS}$  = 400V and  $I_D$  = 50A





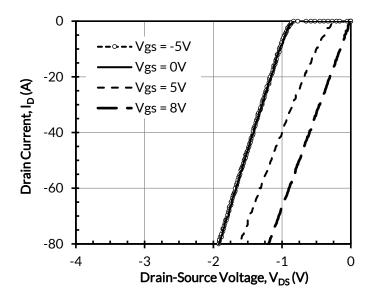








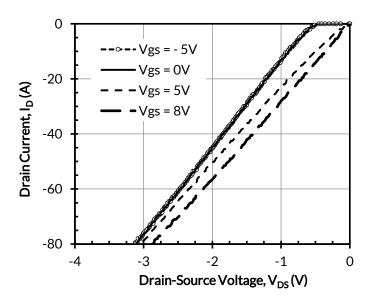




0 **--** Vgs = - 5V -20 Vgs = 5V Drain Current, I<sub>D</sub> (A) **-** Vgs = 8V -40 -60 -80 -3 -2 0 Drain-Source Voltage, V<sub>DS</sub> (V)

Figure 9. 3rd quadrant characteristics at  $T_J = -55$ °C

Figure 10. 3rd quadrant characteristics at  $T_J = 25$ °C



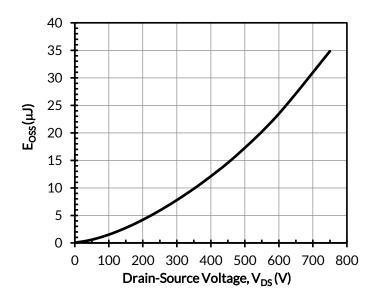


Figure 11. 3rd quadrant characteristics at  $T_J = 175$ °C

Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0V$ 



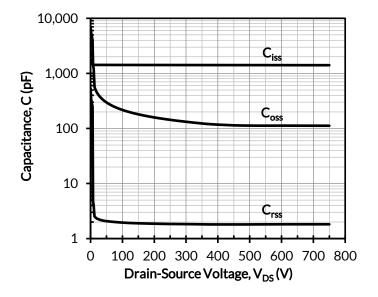












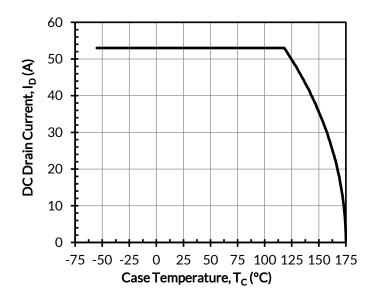


Figure 13. Typical capacitances at f = 100kHz and  $V_{GS}$  = 0V

Figure 14. DC drain current derating

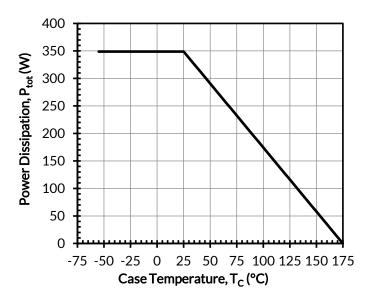


Figure 15. Total power dissipation

Figure 16. Maximum transient thermal impedance















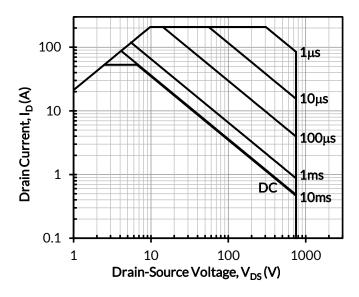


Figure 17. Safe operation area at  $T_C = 25$ °C, D = 0, Parameter t<sub>p</sub>

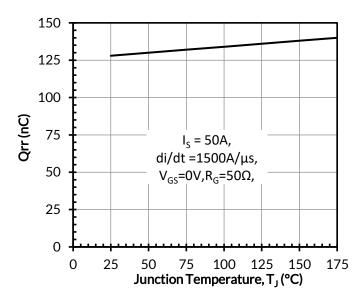


Figure 18. Reverse recovery charge Qrr vs. junction temperature at Vds = 400V

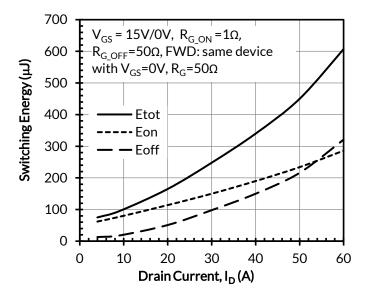
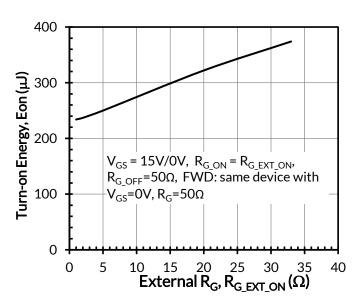


Figure 19. Clamped inductive switching energy vs. drain Figure 20. Clamped inductive switching turn-on energy current at  $V_{DS}$  = 400V and  $T_J$  = 25°C



vs.  $R_{G,EXT\_ON}$  at  $V_{DS}$  = 400V and  $I_D$  = 50A





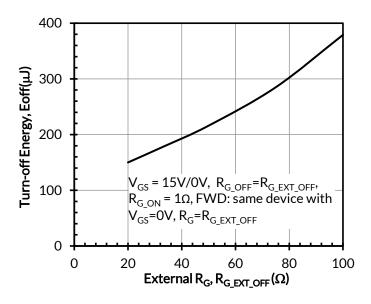












600 500 Switching Energy (µJ) 400 Etot Eon **Eoff** 300 200  $V_{GS} = 15V/0V, R_{G_0N} = 10,$  $R_{G OFF}$ =50 $\Omega$ , FWD: same device with 100  $V_{GS}$ =0V,  $R_{G}$ =50 $\Omega$ 0 25 0 100 125 150 Junction Temperature, T<sub>J</sub> (°C)

Figure 21. Clamped inductive switching turn-off energy vs.  $R_{G EXT OFF}$  at  $V_{DS}$  = 400V and  $I_{D}$  = 50A

Figure 22. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  = 400V and  $I_D$  = 50A

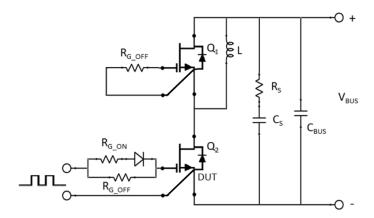


Figure 23. Schematic of the half-bridge mode switching test circuit. Note, a bus RC snubber ( $R_S = 2.5\Omega$ , C<sub>S</sub>=100nF) is used to reduce the power loop high frequency oscillations.













### **Applications Information**

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $C_{oss}$ ), and reverse recovery charge ( $C_{oss}$ ) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

A snubber circuit with a small  $R_{(G)}$ , or gate resistor, provides better EMI suppression with higher efficiency compared to using a high  $R_{(G)}$  value. There is no extra gate delay time when using the snubber circuitry, and a small  $R_{(G)}$  will better control both the turn-off  $V_{(DS)}$  peak spike and ringing duration, while a high  $R_{(G)}$  will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high  $R_{(G)}$ , while greatly reducing  $E_{(OFF)}$  from mid-to-full load range with only a small increase in  $E_{(ON)}$ . Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com

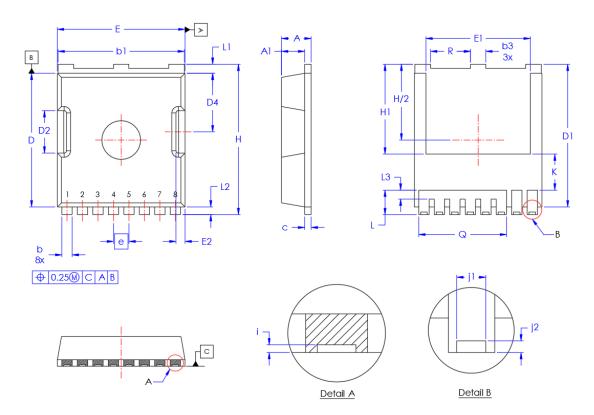
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### **PACKAGE OUTLINE**



TO-LL					
SYMBOL	Va				
	Min	Max			
A	2.15	2.45			
Al	1.80 REF				
b	0.65	0.90			
b1	9.65	9.95			
b3	1.10	1.30			
С	0.40	0.60			
D	10.18	10.58			
DI	10.88	11.28			
D2	3.15	3.45			
D4	4.40	4.70			
Е	9.70	10.10			
El	7.95	8.25			
E2	0.80				
е	1.20 BSC				
Н	11.48	11.88			
HI	6.80	7.10			
i	0.10	REF			
jl	0.46	REF			
j2	0.20	REF			
K	2.80	REF			
L	1.40	2.10			
L1	0.50	0.90			
L2	0.48	0.72			
L3	0.30	0.80			
Q	6.80 REF				
R	3.00	3 20			

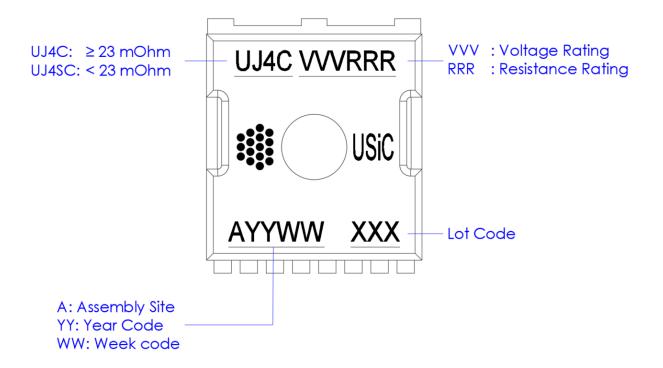
#### Note:

- 1. All dimensions in millimeters
- 2. Dimensions does not include Burrs and Mold Flashes



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#### **PART MARKING**



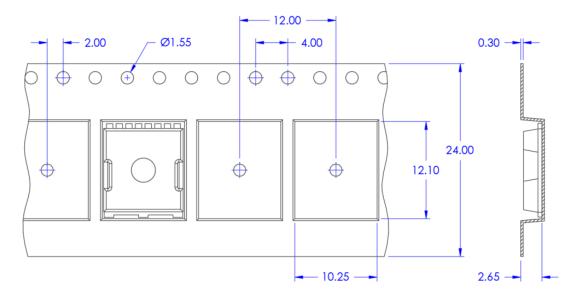
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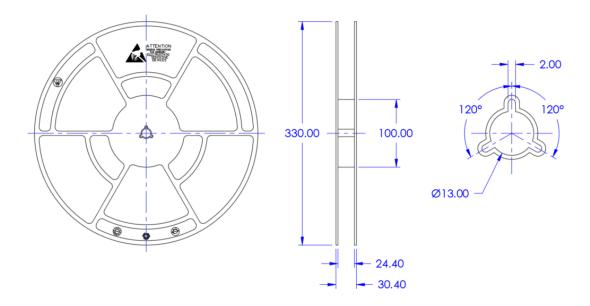
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#### **PACKING TYPE**

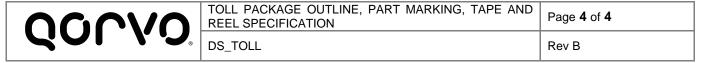
### Carrier Tape



#### Reel



All dimensions in millimeters Quantity per Reel: 2000 units



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#### **REVISION HISTORY**

Revision	Create Date (mm/dd/yyyy)	Description of Change	Initiator of Change
Α	10/13/2023	Initial Production Release	Glenn Galang
В	01/31/2024	Corrected device orientation inside carrier tape pocket (Page 3)	Glenn Galang

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